



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Masayuki SUZUKI et al.

Application No.: 10/670,337

Filed: September 26, 2003

Docket No.: 117330

For: HEATER INSPECTION APPARATUS AND SEMICONDUCTOR MANUFACTURING
APPARATUS HAVING HEATER INSPECTION APPARATUS MOUNTED THEREON

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. Relevance of the non-English language reference is discussed in the present specification. (Ref. 1)
- ☒ 3. An English-language Abstract of the non-English language reference is attached hereto. (Ref. 1)

Respectfully submitted,

James A. Oliff
Registration No. 27,075

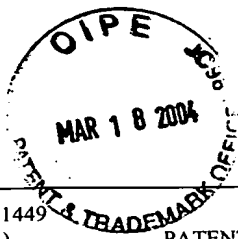
Thomas J. Pardini
Registration No. 30,411

JAO:TJP/amo

Date: March 18, 2004

OLIFF & BERRIDGE, PLC
P.O. Box 19928
Alexandria, Virginia 22320
Telephone: (703) 836-6400

<p>DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461</p>

Sheet 1 of 1Form PTO-1449
(REV. 8-83)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
117330APPLICATION NO.
10/670,337

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANTS
Masayuki SUZUKI et al.FILING DATE
September 26, 2003

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
	1	JP A 4-155828 w/ abst	05/28/1992	Japan		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: March 18, 2004